

### **MOSFET**

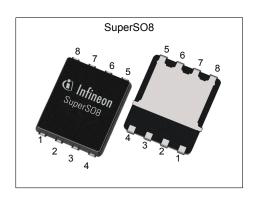
### OptiMOS<sup>™</sup> Power-Transistor, 60 V

#### **Features**

- Optimized for high performance SMPS, e.g. sync. rec.
- 100% avalanche testedSuperior thermal resistance
- N-channel
- Qualified according to JEDEC<sup>1)</sup> for target applications
  Pb-free lead plating; RoHS compliant
  Halogen-free according to IEC61249-2-21

Table 1 **Key Performance Parameters** 

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Parameter	Value	Unit					
V <sub>DS</sub>	60	V					
R <sub>DS(on),max</sub>	2.8	mΩ					
$I_{D}$	132	A					
Qoss	43	nC					
Q <sub>G</sub> (010V)	37	nC					











Type / Ordering Code	rpe / Ordering Code Package		Related Links
BSC028N06NS	PG-TDSON-8	028N06NS	-



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# 1 Maximum ratings at $T_A$ =25 °C, unless otherwise specified

Table 2 Maximum ratings

Damamastan	O b. a.l		Value	S		
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	- - -	- - -	132 83 23	A	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =50K/W <sup>2)</sup>
Pulsed drain current <sup>3)</sup>	I <sub>D,pulse</sub>	-	-	528	Α	<i>T</i> <sub>C</sub> =25 °C
Avalanche energy, single pulse <sup>4)</sup>	<b>E</b> AS	-	-	100	mJ	$I_{\rm D}$ =50 A, $R_{\rm GS}$ =25 $\Omega$
Gate source voltage	V <sub>GS</sub>	-20	-	20	V	-
Power dissipation	P <sub>tot</sub>	-	-	83 2.5	W	T <sub>C</sub> =25 °C T <sub>A</sub> =25 °C, R <sub>thJA</sub> =50 K/W <sup>3)</sup>
Operating and storage temperature	$T_{\rm j},~T_{\rm stg}$	-55	-	150	°C	IEC climatic category; DIN IEC 68-1: 55/150/56

#### 2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol		Values		Unit	Note / Test Condition
Farameter	Symbol	Min.	Min. Typ. Max.		Ullit	Note / Test Condition
Thermal resistance, junction - case, bottom	R <sub>thJC</sub>	-	0.9	1.5	K/W	-
Thermal resistance, junction - case, top	R <sub>thJC</sub>	-	-	20	K/W	-
Device on PCB, 6 cm² cooling area²)	R <sub>thJA</sub>	-	-	50	K/W	-

<sup>&</sup>lt;sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature at 25°C. For higher case temperature please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

2) Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm2 (one layer, 70 µm thick) copper area for drain

connection. PCB is vertical in still air.

3) See Diagram 3 for more detailed information

<sup>&</sup>lt;sup>4)</sup> See Diagram 13 for more detailed information



### **Electrical characteristics**

at T<sub>j</sub>=25 °C, unless otherwise specified

**Static characteristics** Table 4

	0		Value				
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	60	-	-	V	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	
Gate threshold voltage	V <sub>GS(th)</sub>	2.1	2.8	3.3	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=50\ \mu {\rm A}$	
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.5 10	1 100	μΑ	V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C	
Gate-source leakage current	$I_{\mathrm{GSS}}$	-	10	100	nA	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	2.5 3.4	2.8 4.2	mΩ	V <sub>GS</sub> =10 V, I <sub>D</sub> =50 A V <sub>GS</sub> =6 V, I <sub>D</sub> =12.5 A	
Gate resistance <sup>1)</sup>	R <sub>G</sub>	-	1.3	1.95	Ω	-	
Transconductance	$g_{fs}$	50	100	-	S	$ V_{DS}  > 2 I_D R_{DS(on)max}, I_D = 50 A$	

Table 5 **Dynamic characteristics** 

Danamatan	Ob. a.l.	Values				
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance <sup>1)</sup>	C <sub>iss</sub>	2025	2700	3375	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, f=1 MHz
Output capacitance <sup>1)</sup>	Coss	495	660	825	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, <i>f</i> =1 MHz
Reverse transfer capacitance <sup>1)</sup>	C <sub>rss</sub>	8.5	28	56	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, <i>f</i> =1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	11	22	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =3 $\Omega$
Rise time	t <sub>r</sub>	-	38	57	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =3 $\Omega$
Turn-off delay time	$t_{ m d(off)}$	-	19	38	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =3 $\Omega$
Fall time	t <sub>f</sub>	-	8	16	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =3 $\Omega$

Gate charge characteristics<sup>2)</sup> Table 6

Parameter	Ole al		Values			Nata / Tank One distant
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q <sub>gs</sub>	9	12	16.5	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Gate charge at threshold	$Q_{g(th)}$	6	8	11	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Gate to drain charge	$Q_{ m gd}$	5	7	10.3	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Switching charge	Q <sub>sw</sub>	8	12	17	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total	Qg	31	37	49	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Gate plateau voltage	V <sub>plateau</sub>	4.0	4.6	5.2	V	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total, sync. FET	Q <sub>g(sync)</sub>	27	33	43	nC	V <sub>DS</sub> =0.1 V, V <sub>GS</sub> =0 to 10 V
Output charge	Q <sub>oss</sub>	32	43	54	nC	V <sub>DD</sub> =30 V, V <sub>GS</sub> =0 V

Defined by design. Not subject to production test See "Gate charge waveforms" for parameter definition. Defined by design, not subject to production test

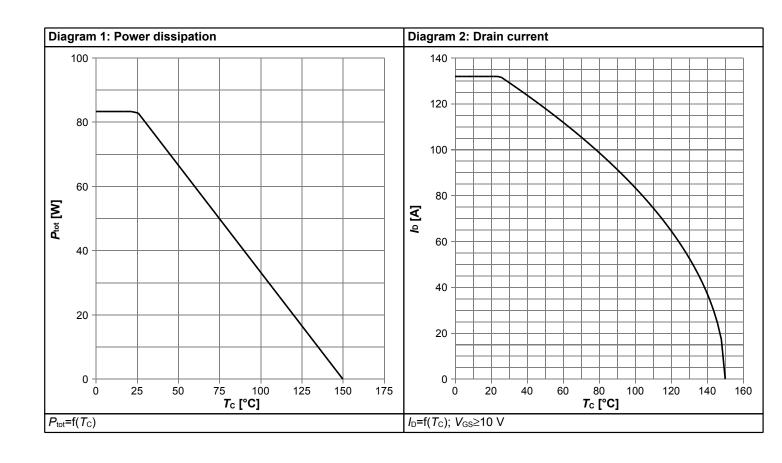


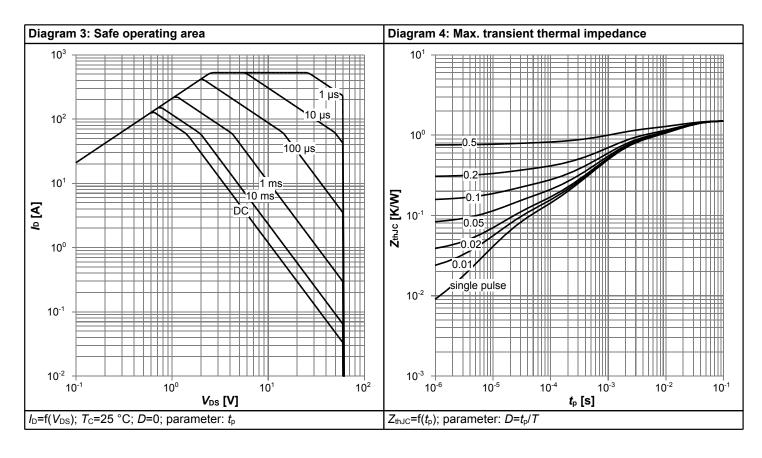
### Table 7 Reverse diode

Douglaston	Cumbal		Value	5	1111111	Nata / Tant Candition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Diode continuous forward current	Is	-	-	100	Α	<i>T</i> <sub>C</sub> =25 °C	
Diode pulse current	I <sub>S,pulse</sub>	-	-	528	Α	<i>T</i> <sub>C</sub> =25 °C	
Diode forward voltage	V <sub>SD</sub>	-	0.9	1.2	V	V <sub>GS</sub> =0 V, I <sub>F</sub> =50 A, T <sub>j</sub> =25 °C	
Reverse recovery time <sup>1)</sup>	t <sub>rr</sub>	14	35	56	ns	V <sub>R</sub> =30 V, I <sub>F</sub> =50 A, d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/μs	
Reverse recovery charge <sup>1)</sup>	Qrr	14	29	58	nC	$V_R$ =30 V, $I_F$ =50 A, $di_F/dt$ =100 A/ $\mu$ s	

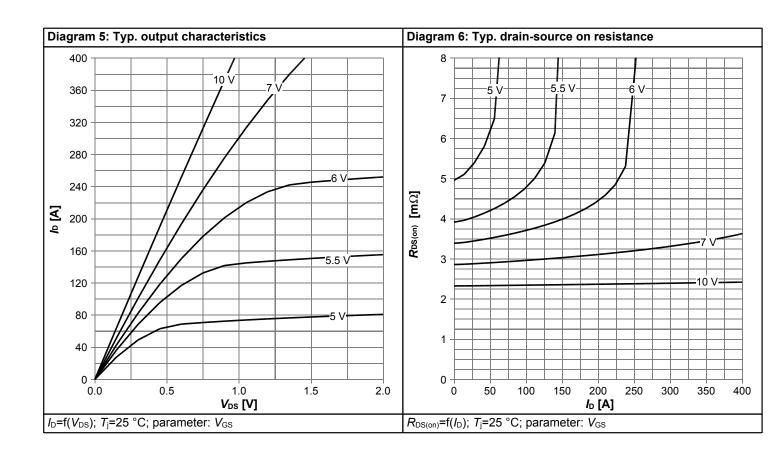


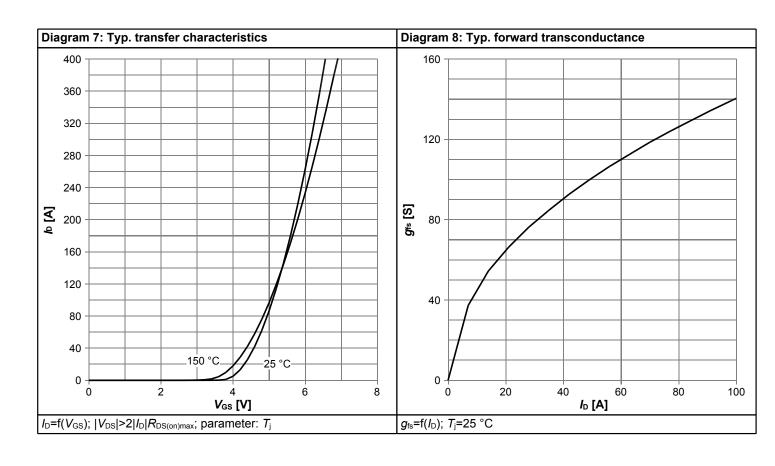
### 4 Electrical characteristics diagrams



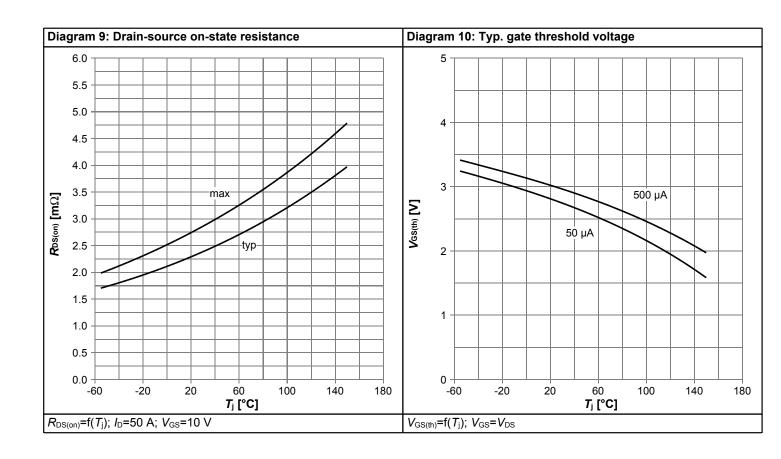


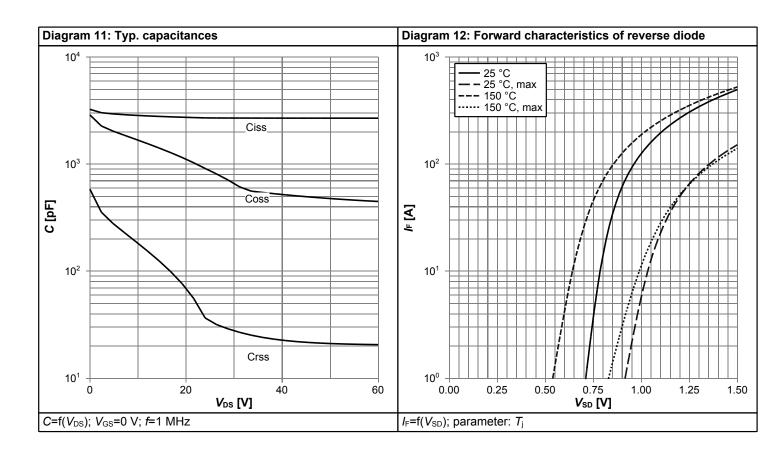




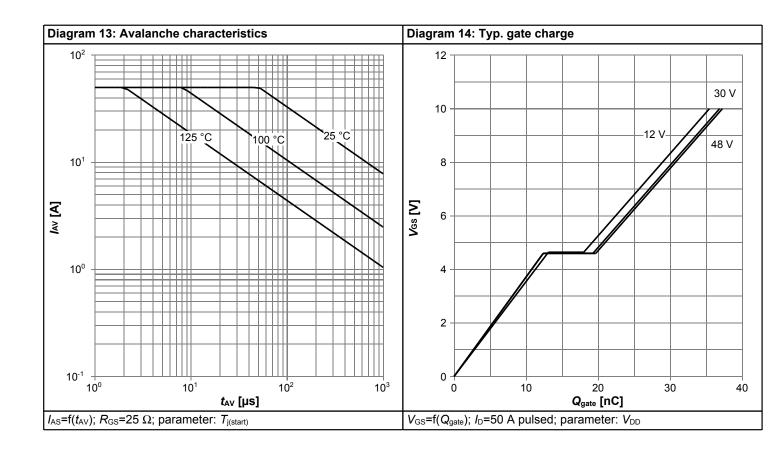


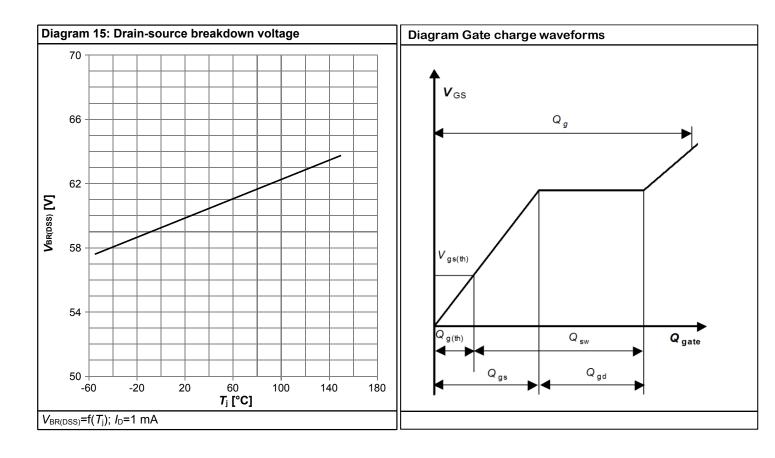






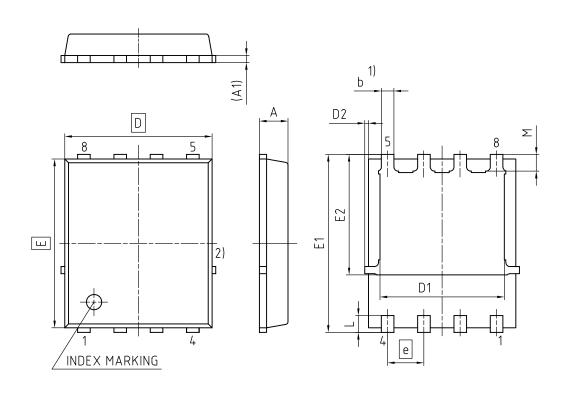








## 5 Package Outlines



1) EXCLUDING MOLD FLASH
2) REMOVAL ON MOLD GATE
INTRUSION 0.1 MM
PROTRUSION 0.1 MM
LEAD LENGTH UP TO ANTI FLASH LINE
ALL METAL SURFACES ARE PLATED, EXCEPT AREA OF CUT

DIMENSION	MILLIM	ETERS				
DIMENSION	MIN.	MAX.				
Α	0.90	1.20				
A1	0.15	0.35				
b	0.34	0.54				
D	4.80	5.35				
D1	3.90	4.40				
D2	0.03	0.23				
E	5.70	6.10				
E1	5.90	6.42				
E2	3.88	4.31				
е	1.27					
L	0.45	0.71				
M	0.45	0.69				

<b>DOCUMENT NO.</b> Z8B00003332			
REVISION 07			
SCALE 10:1			
0 1 2 3mm			
EUROPEAN PROJECTION			
ISSUE DATE			
06.06.2019			

Figure 1 Outline PG-TDSON-8, dimensions in mm



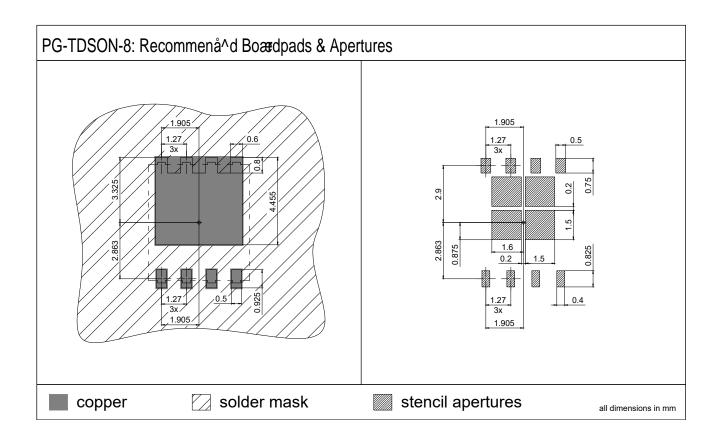
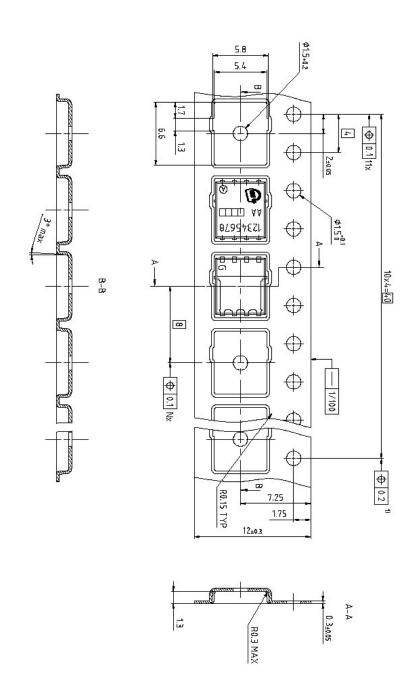


Figure 2 Outline Boardpads (TDSON-8), dimensions in mm





Dimension in mm

Figure 3 Outline Tape (TDSON-8)

# OptiMOS TM Power-Transistor , 60 V BSC028N06NS



#### Revision History

#### BSC028N06NS

Revision: 2020-09-21, Rev. 2.5

#### **Previous Revision**

Revision	Date	Subjects (major changes since last revision)
2.3	2014-11-10	Added RthJC_typ, updated outline and footprint drawings, insert footnote "Defined by design"
2.4	2020-02-04	Update package drawings
2.5	2020-09-21	Update current rating

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